

# 8-Stage Shift/Store Register with Three-State Outputs

# MC14094B

The MC14094B combines an 8-stage shift register with a data latch for each stage and a 3-state output from each latch.

Data is shifted on the positive clock transition and is shifted from the seventh stage to two serial outputs. The  $Q_S$  output data is for use in high-speed cascaded systems. The  $Q_S$  output data is shifted on the following negative clock transition for use in low-speed cascaded systems.

Data from each stage of the shift register is latched on the negative transition of the strobe input. Data propagates through the latch while strobe is high.

Outputs of the eight data latches are controlled by 3-state buffers which are placed in the high-impedance state by a logic Low on Output Enable.

#### **Features**

- 3-State Outputs
- Capable of Driving Two Low-Power TTL Loads or One Low-Power Schottky TTL Load Over the Rated Temperature Range
- Input Diode Protection
- Data Latch
- Dual Outputs for Data Out on Both Positive and Negative Clock Transitions
- Useful for Serial-to-Parallel Data Conversion
- Pin-for-Pin Compatible with CD4094B
- NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

# A STATE OF THE STA

SOIC-16 D SUFFIX CASE 751B



#### MARKING DIAGRAMS





SOIC-16

A = Assembly Location

WL, L = Wafer Lot YY, Y = Year WW, W = Work Week G or = Pb-Free Indicator

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

#### **MAXIMUM RATINGS** (Voltages Referenced to V<sub>SS</sub>)

Symbol	Parameter	Value	Unit
V <sub>DD</sub>	DC Supply Voltage Range	-0.5 to +18.0	V
V <sub>in</sub> , V <sub>out</sub>	Input or Output Voltage Range (DC or Transient)	-0.5 to V <sub>DD</sub> + 0.5	V
I <sub>in</sub> , I <sub>out</sub>	Input or Output Current (DC or Transient) per Pin	±10	mA
P <sub>D</sub>	Power Dissipation, per Package (Note 1)	500	mW
T <sub>A</sub>	Ambient Temperature Range	-55 to +125	°C
T <sub>stg</sub>	Storage Temperature Range	-65 to +150	°C
TL	Lead Temperature (8–Second Soldering)	260	°C

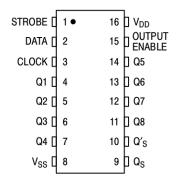
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high–impedance circuit. For proper operation,  $V_{in}$  and  $V_{out}$  should be constrained to the range  $V_{SS} \le (V_{in} \text{ or } V_{out}) \le V_{DD}$ .

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either V<sub>SS</sub> or V<sub>DD</sub>). Unused outputs must be left open.

<sup>1.</sup> Temperature Derating: "D/DW" Packages: -7.0 mW/°C From 65°C To 125°C

# **PIN ASSIGNMENT**



# **TRUTH TABLE**

	Output	Parallel Outputs Serial Outp			Parallel Outputs		Outputs
Clock	Enable	Strobe	Data	Q1	Q <sub>N</sub>	Q <sub>S</sub> *	Q′s
	0	Х	Х	Z	Z	Q7	No Chg.
~	0	Х	Х	Z	Z	No Chg.	Q7
	1	0	Х	No Chg.	No Chg.	Q7	No Chg.
	1	1	0	0	Q <sub>N</sub> -1	Q7	No Chg.
	1	1	1	1	Q <sub>N</sub> -1	Q7	No Chg.
$\overline{}$	1	1	1	No Chg.	No Chg.	No Chg.	Q7

Z = High Impedance X = Don't Care

# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
MC14094BDG	SOIC-16 (Pb-Free)	48 Units / Rail
MC14094BDR2G	SOIC-16 (Pb-Free)	2500 Units / Tape & Reel
NLV14094BDR2G*	SOIC-16 (Pb-Free)	2500 Units / Tape & Reel
MC14094BDTR2G	TSSOP-16 (Pb-Free)	2500 Units / Tape & Reel
NLV14094BDTR2G*	TSSOP-16 (Pb-Free)	2500 Units / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>\*</sup> At the positive clock edge, information in the 7th shift register stage is transferred to Q8 and Qs.

<sup>\*</sup>NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable.

#### **ELECTRICAL CHARACTERISTICS** (Voltages Referenced to V<sub>SS</sub>)

				-55	5° <b>C</b>		25°C		125	5°C	
Characteristic		Symbol	V <sub>DD</sub> Vdc	Min	Max	Min	Typ (Note 2)	Max	Min	Max	Unit
Output Voltage V <sub>in</sub> = V <sub>DD</sub> or 0	"0" Level	V <sub>OL</sub>	5.0 10 15	- - -	0.05 0.05 0.05	- - -	0 0 0	0.05 0.05 0.05	- - -	0.05 0.05 0.05	Vdc
V <sub>in</sub> = 0 or V <sub>DD</sub>	"1" Level	V <sub>OH</sub>	5.0 10 15	4.95 9.95 14.95	- - -	4.95 9.95 14.95	5.0 10 15	- - -	4.95 9.95 14.95	- - -	Vdc
Input Voltage (V <sub>O</sub> = 4.5 or 0.5 Vdc) (V <sub>O</sub> = 9.0 or 1.0 Vdc) (V <sub>O</sub> = 13.5 or 1.5 Vdc)	"0" Level	V <sub>IL</sub>	5.0 10 15	- - -	1.5 3.0 4.0	- - -	2.25 4.50 6.75	1.5 3.0 4.0	- - -	1.5 3.0 4.0	Vdc
$(V_O = 0.5 \text{ or } 4.5 \text{ Vdc})$ $(V_O = 1.0 \text{ or } 9.0 \text{ Vdc})$ $(V_O = 1.5 \text{ or } 13.5 \text{ Vdc})$	"1" Level	V <sub>IH</sub>	5.0 10 15	3.5 7.0 11	- - -	3.5 7.0 11	2.75 5.50 8.25		3.5 7.0 11	- - -	Vdc
Output Drive Current $ (V_{OH} = 2.5 \text{ Vdc}) $ $ (V_{OH} = 4.6 \text{ Vdc}) $ $ (V_{OH} = 9.5 \text{ Vdc}) $ $ (V_{OH} = 13.5 \text{ Vdc}) $	Source	I <sub>OH</sub>	5.0 5.0 10 15	-3.0 -0.64 -1.6 -4.2	- - -	-2.4 -0.51 -1.3 -3.4	-4.2 -0.88 -2.25 -8.8	- - -	-1.7 -0.36 -0.9 -2.4	- - -	mAdc
$(V_{OL} = 0.4 \text{ Vdc})$ $(V_{OL} = 0.5 \text{ Vdc})$ $(V_{OL} = 1.5 \text{ Vdc})$	Sink	l <sub>OL</sub>	5.0 10 15	0.64 1.6 4.2	- - -	0.51 1.3 3.4	0.88 2.25 8.8	-	0.36 0.9 2.4	- - -	mAdc
Input Current		l <sub>in</sub>	15	-	±0.1	-	±0.00001	±0.1	-	±1.0	μAdc
Input Capacitance (V <sub>in</sub> = 0)		C <sub>in</sub>	ı	-	1	-	5.0	7.5	1	-	pF
Quiescent Current (Per Package)		I <sub>DD</sub>	5.0 10 15		5.0 10 20		0.005 0.010 0.015	5.0 10 20		150 300 600	μAdc
Total Supply Current (Notes (Dynamic plus Quiescer Per Package) (C <sub>L</sub> = 50 pF on all outpu buffers switching)	nt,	lτ	5.0 10 15			$I_T = ($	1.1 μΑ/kHz) f 14 μΑ/kHz) f 40 μΑ/kHz) f	+ I <sub>DD</sub>			μAdc
3-State Output Leakage Co	urrent	I <sub>TL</sub>	15	-	±0.1	-	±0.0001	±0.1	-	±3.0	μΑ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.

- 3. The formulas given are for the typical characteristics only at 25°C.
- 4. To calculate total supply current at loads other than 50 pF:

$$I_T(C_L) = I_T(50 \text{ pF}) + (C_L - 50) \text{ Vfk}$$

where:  $I_T$  is in  $\mu A$  (per package),  $C_L$  in pF,  $V = (V_{DD} - V_{SS})$  in volts, f in kHz is input frequency, and k = 0.001.

# SWITCHING CHARACTERISTICS (Note 5) ( $C_L = 50 \text{ pF}, T_A = 25 ^{\circ}\text{C}$ )

Characteristic	Symbol	V <sub>DD</sub> Vdc	Min	Typ (Note 6)	Max	Unit
Output Rise and Fall Time $t_{TLH}, t_{THL} = (1.35 \text{ ns/pF}) \text{ C}_L + 33 \text{ ns}$ $t_{TLH}, t_{THL} = (0.6 \text{ ns/pF}) \text{ C}_L + 20 \text{ ns}$ $t_{TLH}, t_{THL} = (0.4 \text{ ns/pF}) \text{ C}_L + 20 \text{ ns}$	t <sub>TLH</sub> , t <sub>THL</sub>	5.0 10 15	- - -	100 50 40	200 100 80	ns
Propagation Delay Time (Figure 1)  Clock to Serial out QS $t_{PLH}$ , $t_{PHL}$ = (0.90 ns/pF) $C_L$ + 305 ns $t_{PLH}$ , $t_{PHL}$ = (0.36 ns/pF) $C_L$ + 107 ns $t_{PLH}$ , $t_{PHL}$ = (0.26 ns/pF) $C_L$ + 82 ns	t <sub>PLH</sub> , t <sub>PHL</sub>	5.0 10 15	- - -	350 125 95	600 250 190	ns
Clock to Serial out Q'S $t_{PLH}$ , $t_{PHL} = (0.90 \text{ ns/pF}) C_L + 350 \text{ ns}$ $t_{PLH}$ , $t_{PHL} = (0.36 \text{ ns/pF}) C_L + 149 \text{ ns}$ $t_{PLH}$ , $t_{PHL} = (0.26 \text{ ns/pF}) C_L + 62 \text{ ns}$		5.0 10 15	- - -	230 110 75	460 220 150	
Clock to Parallel out $t_{PLH},t_{PHL}=(0.90\;ns/pF)\;C_L+375\;ns$ $t_{PLH},t_{PHL}=(0.35\;ns/pF)\;C_L+177\;ns$ $t_{PLH},t_{PHL}=(0.26\;ns/pF)\;C_L+122\;ns$		5.0 10 15	- - -	420 195 135	840 390 270	
Strobe to Parallel out $t_{PLH}, t_{PHL} = (0.90 \text{ ns/pF}) \text{ C}_L + 245 \text{ ns}$ $t_{PLH}, t_{PHL} = (0.36 \text{ ns/pF}) \text{ C} \text{ L} + 127 \text{ ns}$ $t_{PLH}, t_{PHL} = (0.26 \text{ ns/pF}) \text{ C}_L + 87 \text{ ns}$		5.0 10 15	- - -	290 145 100	580 290 200	
Output Enable to Output $t_{PHZ}, t_{PZL} = (0.90 \text{ ns/pF}) \text{ C}_L + 95 \text{ ns}$ $t_{PHZ}, t_{PZL} = (0.36 \text{ ns/PF}) \text{ C}_L + 57 \text{ ns}$ $t_{PHZ}, t_{PZL} = (0.26 \text{ ns/pF}) \text{ C}_L + 42 \text{ ns}$	t <sub>PHZ</sub> , t <sub>PZL</sub>	5.0 10 15	- - -	140 75 55	280 150 110	
$t_{PLZ}, t_{PZH} = (0.90 \text{ ns/pF}) \text{ C}_L + 180 \text{ ns}$ $t_{PLZ}, t_{PZH} = (0.36 \text{ ns/pF}) \text{ C}_L + 77 \text{ ns}$ $t_{PLZ}, t_{PZH} = (0.26 \text{ ns/pF}) \text{ C}_L + 57 \text{ ns}$	t <sub>PLZ</sub> , t <sub>PZH</sub>	5.0 10 15	- - -	225 95 70	450 190 140	
Setup Time Data in to Clock	t <sub>su</sub>	5.0 10 15	125 55 35	60 30 20	- - -	ns
Hold Time Clock to Data	t <sub>h</sub>	5.0 10 15	0 20 20	- 40 - 10 0	- - -	ns
Clock Pulse Width, High	t <sub>WH</sub>	5.0 10 15	200 100 83	100 50 40	- - -	ns
Clock Rise and Fall Time	t <sub>r(CI)</sub> t <sub>f(CI)</sub>	5 10 15	- - -	- - -	15 5.0 4.0	μs
Clock Pulse Frequency	f <sub>cl</sub>	5.0 10 15	- - -	2.5 5.0 6.0	1.25 2.5 3.0	MHz
Strobe Pulse Width	t <sub>WL</sub>	5.0 10 15	200 80 70	100 40 35	- - -	ns

<sup>5.</sup> The formulas given are for the typical characteristics only at 25°C.
6. Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.

#### **3-STATE TEST CIRCUIT**

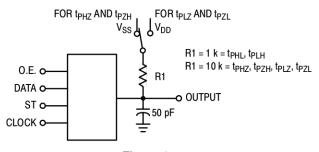
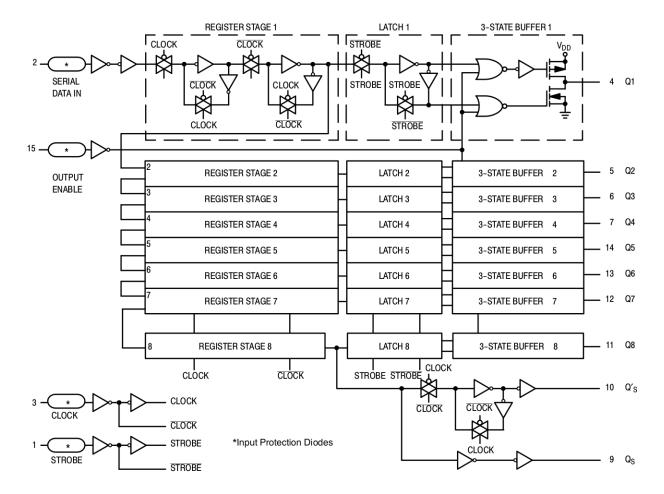
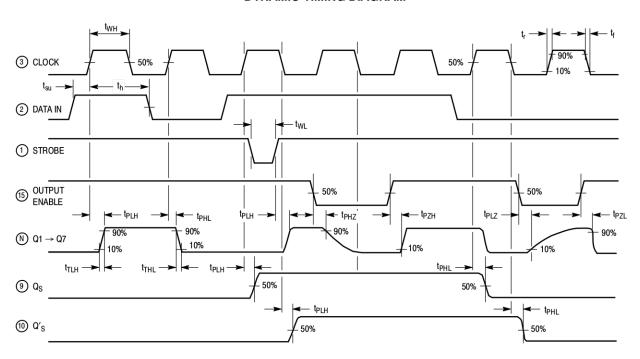


Figure 1.

#### **BLOCK DIAGRAM**

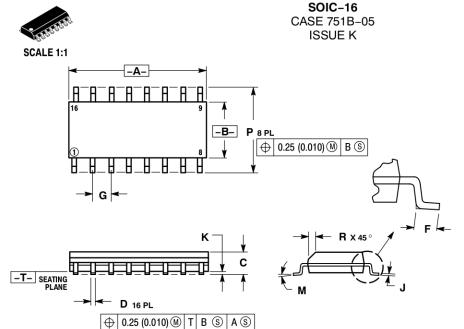


# **DYNAMIC TIMING DIAGRAM**



# **MECHANICAL CASE OUTLINE**





**DATE 29 DEC 2006** 

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
- PHOTHOSION.

  MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.

  DIMENSION D DOES NOT INCLUDE DAMBAR
  PROTRUSION. ALLOWABLE DAMBAR PROTRUSION
  SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D

  DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	9.80	10.00	0.386	0.393	
В	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.054	0.068	
D	0.35	0.49	0.014	0.019	
F	0.40	1.25	0.016	0.049	
G	1.27	BSC	0.050 BSC		
J	0.19	0.25	0.008	0.009	
K	0.10	0.25	0.004	0.009	
M	0°	7°	0°	7°	
Р	5.80	6.20	0.229	0.244	
R	0.25	0.50	0.010	0.019	

STYLE 1:		STYLE 2:		STYLE 3:		STYLE 4:			
PIN 1.	COLLECTOR	PIN 1.	CATHODE	PIN 1.	COLLECTOR, DYE #1	PIN 1.	COLLECTOR, DYE #1		
2.	BASE	2.	ANODE	2.	BASE, #1	2.	COLLECTOR, #1		
3.	EMITTER	3.	NO CONNECTION	3.	EMITTER, #1	3.	COLLECTOR, #2		
4.	NO CONNECTION	4.	CATHODE	4.	COLLECTOR, #1	4.	COLLECTOR, #2		
5.	EMITTER	5.	CATHODE	5.	COLLECTOR, #2	5.	COLLECTOR, #3		
6.	BASE	6.	NO CONNECTION	6.	BASE, #2	6.	COLLECTOR, #3		
7.	COLLECTOR	7.	ANODE	7.	EMITTER, #2	7.	COLLECTOR, #4		
8.	COLLECTOR	8.	CATHODE	8.	COLLECTOR, #2	8.	COLLECTOR, #4		
9.	BASE	9.	CATHODE	9.	COLLECTOR, #3	9.	BASE, #4		
10.	EMITTER	10.	ANODE	10.	BASE, #3	10.	EMITTER, #4		
11.	NO CONNECTION	11.	NO CONNECTION	11.	EMITTER, #3	11.	BASE, #3		
12.	EMITTER	12.	CATHODE	12.	COLLECTOR, #3	12.	EMITTER, #3		
13.	BASE	13.	CATHODE	13.	COLLECTOR, #4	13.	BASE, #2	COL DEDING	COOTDOINT
14.	COLLECTOR	14.	NO CONNECTION	14.	BASE, #4	14.	EMITTER, #2	SOLDERING	FOOTPRINT
15.	EMITTER	15.	ANODE	15.	EMITTER, #4	15.	BASE, #1	8	X
16.	COLLECTOR	16.	CATHODE	16.	COLLECTOR, #4	16.	EMITTER, #1		40 →
								<u> </u>	40
STYLE 5:		STYLE 6:		STYLE 7:					16X 1.12 <
PIN 1.	DRAIN, DYE #1		CATHODE	PIN 1.	SOURCE N-CH				
2.	DRAIN, #1		CATHODE	2.	COMMON DRAIN (OUTPU	T)		1	16 🗍
3.	DRAIN, #2	3.	CATHODE	3.	COMMON DRAIN (OUTPU			<b>,</b>	'
4.	DRAIN, #2			4.	GATE P-CH	•,		<del>-</del>	
5.	DRAIN, #3	5.	CATHODE	5.	COMMON DRAIN (OUTPU	T)	16X	T	🖳
6.	DRAIN, #3	6.	CATHODE	6.	COMMON DRAIN (OUTPU		0.58	J [	' <u> </u>
7.	DRAIN, #4	7.		7.	COMMON DRAIN (OUTPU		0.56		
8.	DRAIN, #4	8.	CATHODE	8.	SOURCE P-CH	- /			
9.	GATE, #4	9.	ANODE	9.	SOURCE P-CH				
10.	SOURCE, #4	10.	ANODE	10.	COMMON DRAIN (OUTPU	T)			
11.	GATE, #3	11.	ANODE	11.					
12.	SOURCE, #3	12.	ANODE	12.	COMMON DRAIN (OUTPU	T)			
13.	GATE, #2	13.	ANODE	13.	GATE N-CH	'			L
14.	SOURCE, #2	14.	ANODE	14.	COMMON DRAIN (OUTPU	T)		_	
15.	GATE, #1	15.	ANODE	15.					<del>L</del> _+_
16.	SOURCE, #1	16.	ANODE	16.	SOURCE N-CH				
								□ 8	9 +
								<b></b> _	ı · · — ↑
									DIMENSIONS: MILLIMETERS
									DIMENSIONS: MILLIMETERS

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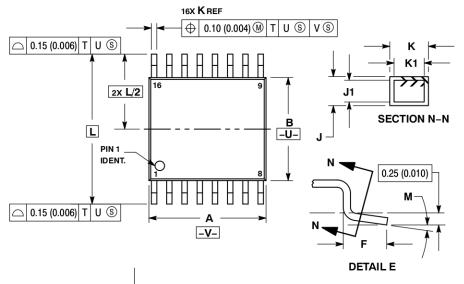
D

-T- SEATING



TSSOP-16 CASE 948F-01 **ISSUE B** 

**DATE 19 OCT 2006** 



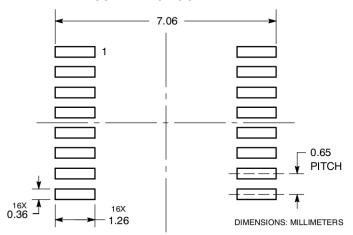
#### NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT
- MOLD FLASH OF GATE BURHS SHALL NOT EXCEED 0.15 (0.006) PER SIDE. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
- DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
- 7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.90	5.10	0.193	0.200	
В	4.30	4.50	0.169	0.177	
С		1.20		0.047	
D	0.05	0.15	0.002	0.006	
F	0.50	0.75	0.020	0.030	
G	0.65	BSC	0.026 BSC		
Н	0.18	0.28	0.007	0.011	
J	0.09	0.20	0.004	0.008	
J1	0.09	0.16	0.004	0.006	
K	0.19	0.30	0.007	0.012	
K1	0.19	0.25	0.007	0.010	
L	6.40	BSC	0.252 BSC		
м	٥°	8 0	٥°	g °	

#### SOLDERING FOOTPRINT

G



#### **GENERIC** MARKING DIAGRAM\*



= Specific Device Code XXXX Α = Assembly Location

= Wafer Lot L Υ = Year W = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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